

Supporting Information

General and Precise Carbon Confinement of Functional Nanostructures Derived from Assembled Metal-Phenolic Network for Enhanced Lithium Storage

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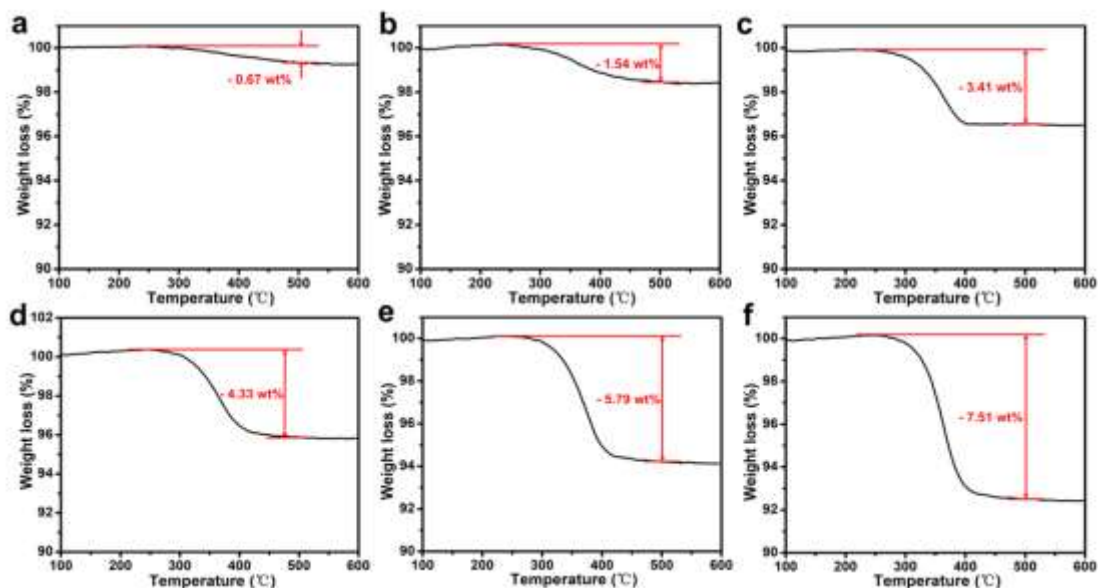


Fig. S1 (a-f) TG curves of SnO₂@C-Fe₂O₃-1, SnO₂@C-Fe₂O₃-3, SnO₂@C-Fe₂O₃-7, SnO₂@C-Fe₂O₃-10, SnO₂@C-Fe₂O₃-15 and SnO₂@C-Fe₂O₃-20, respectively, in air at 10 °C min⁻¹.

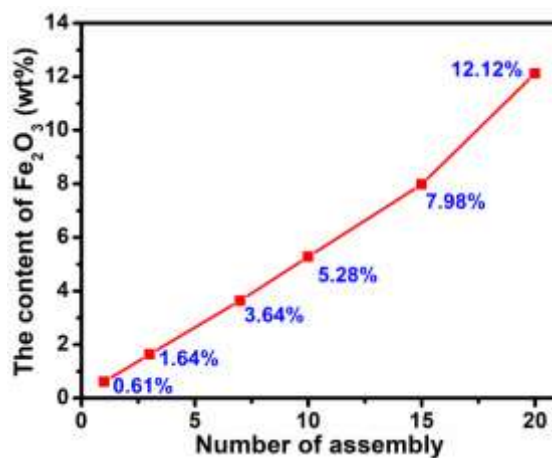


Fig. S2 The relationship between the content of Fe₂O₃ and the number of assembly layer according to the ICP results.

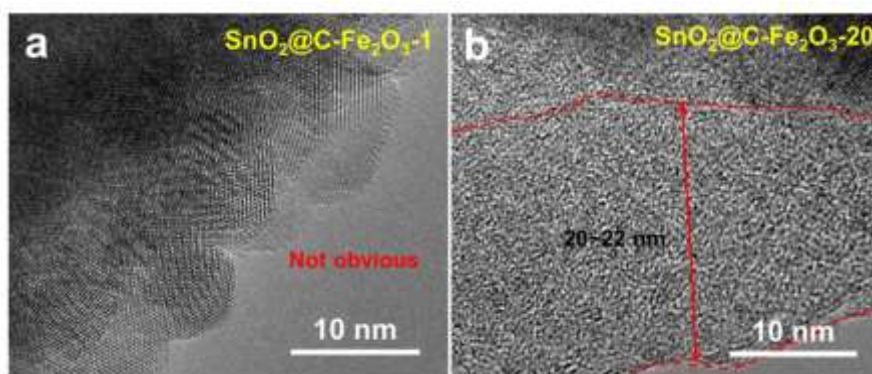


Fig. S3 (a, b) HRTEM images of $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-1}$ and $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-20}$, respectively.

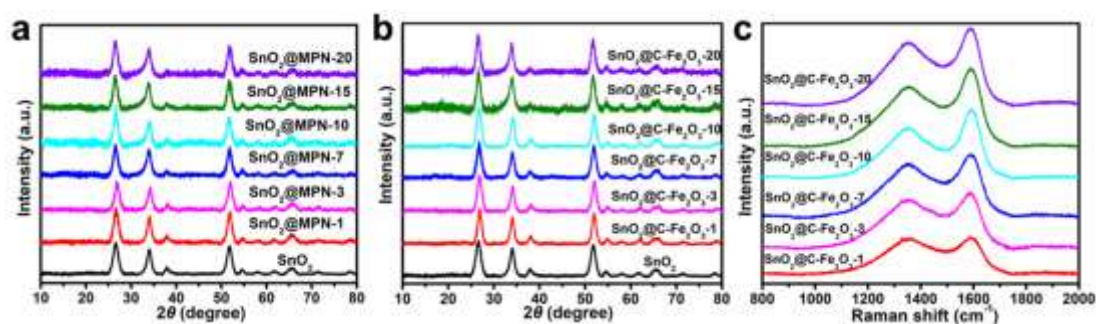


Fig. S4 (a) XRD patterns of SnO_2 , $\text{SnO}_2@\text{MPN-1}$, $\text{SnO}_2@\text{MPN-3}$, $\text{SnO}_2@\text{MPN-7}$, $\text{SnO}_2@\text{MPN-10}$, $\text{SnO}_2@\text{MPN-15}$ and $\text{SnO}_2@\text{MPN-20}$. (b) XRD patterns of SnO_2 , $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-1}$, $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-3}$, $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-7}$, $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-10}$, $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-15}$ and $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-20}$. (c) Raman spectra of $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-1}$, $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-3}$, $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-7}$, $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-10}$, $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-15}$ and $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-20}$.

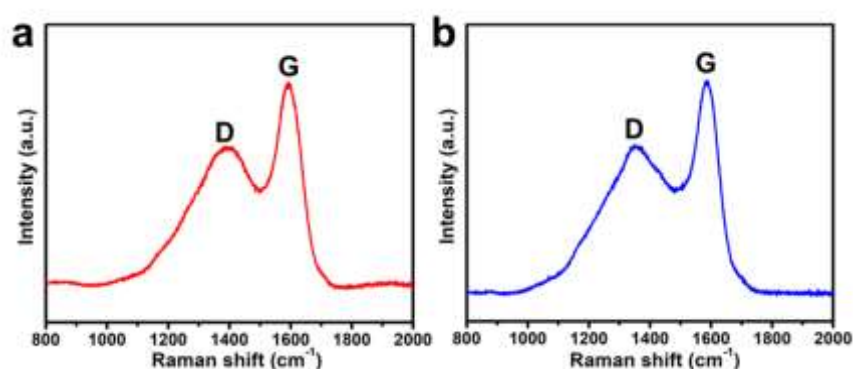


Fig. S5 (a, b) Raman spectra of the pure carbon derived from gallic acid and pyrogallol acid, respectively.

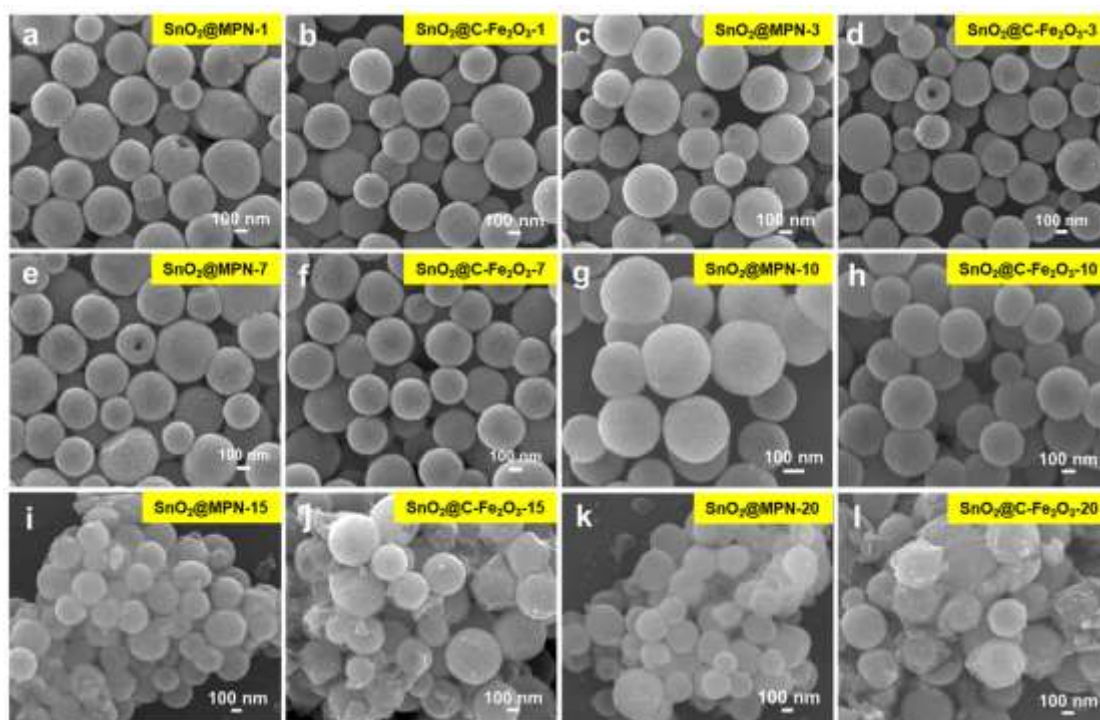


Fig. S6 (a, c, e, g, i and k) SEM images of SnO₂@MPN-1, SnO₂@MPN-3, SnO₂@MPN-7, SnO₂@MPN-10, SnO₂@MPN-15 and SnO₂@MPN-20, respectively. (b, d, f, h, j and l) SEM images of SnO₂@C-Fe₂O₃-1, SnO₂@C-Fe₂O₃-3, SnO₂@C-Fe₂O₃-7, SnO₂@C-Fe₂O₃-10, SnO₂@C-Fe₂O₃-15 and SnO₂@C-Fe₂O₃-20, respectively.

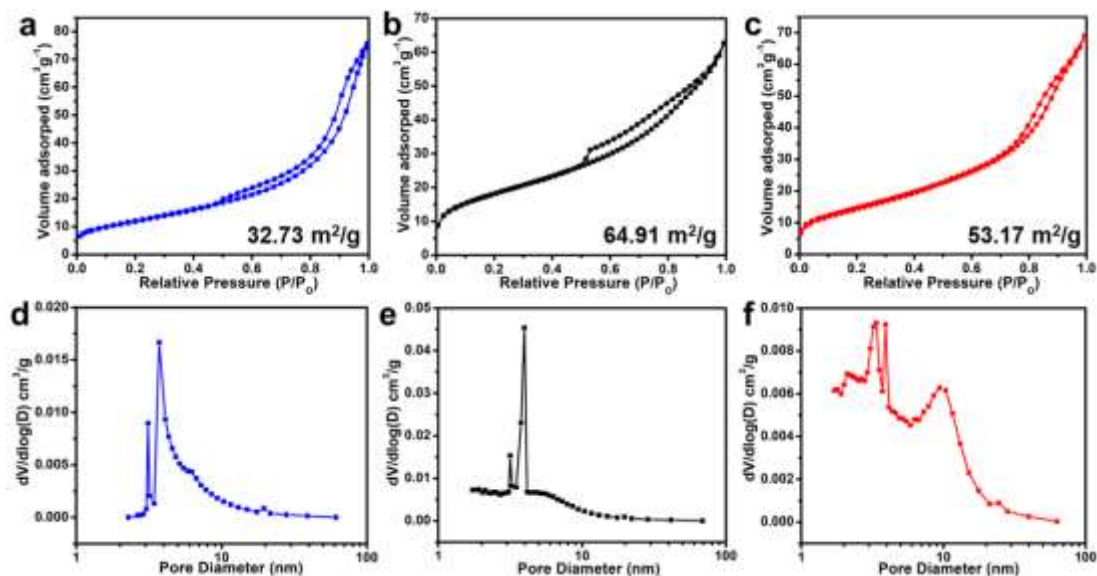


Fig. S7 (a, d) N₂ adsorption/desorption isotherm and the corresponding pore size distribution of SnO₂, respectively. (b, e) N₂ adsorption/desorption isotherm and the corresponding pore size distribution of SnO₂@MPN-10, respectively. (c, f) N₂

adsorption/desorption isotherm and the corresponding pore size distribution of SnO₂@C-Fe₂O₃-10, respectively.

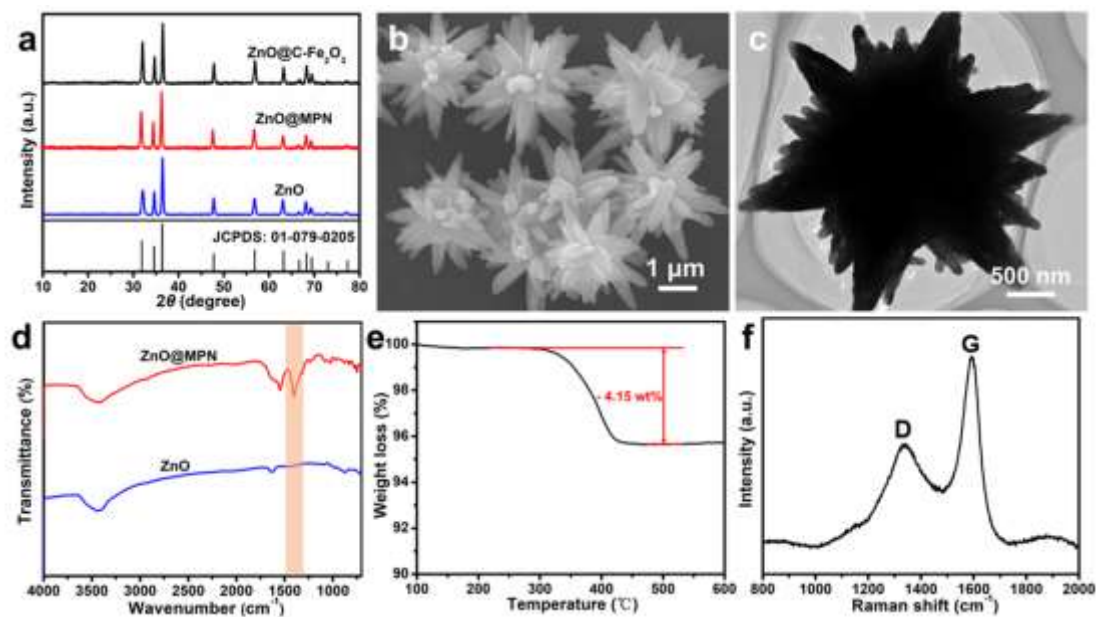


Fig. S8 (a) XRD patterns of ZnO, ZnO@MPN and ZnO@C-Fe₂O₃ microflowers. (b, c) SEM and TEM images of ZnO microflowers, respectively. (d) FT-IR spectra of ZnO and ZnO@MPN. (e, f) TG curve and Raman spectrum of ZnO@C-Fe₂O₃, respectively.

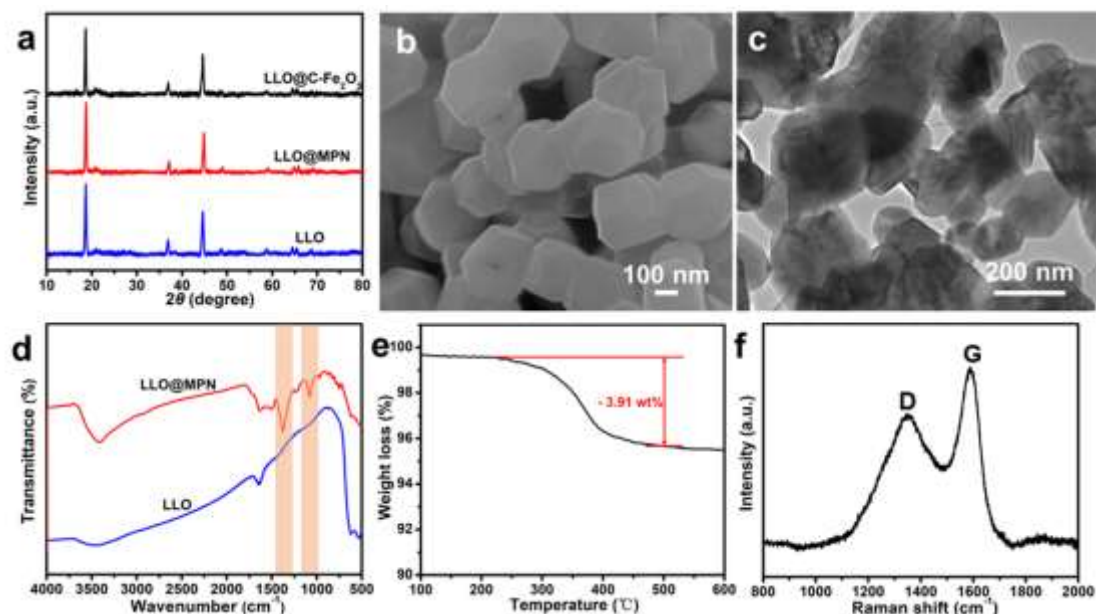


Fig. S9 (a) XRD patterns of LLO, LLO@MPN and LLO@C-Fe₂O₃ nanoparticles. (b, c) SEM and TEM images of LLO nanoparticles, respectively. (d) FT-IR spectra of LLO and LLO@MPN. (e, f) TG curve and Raman spectrum of LLO@C-Fe₂O₃, respectively.

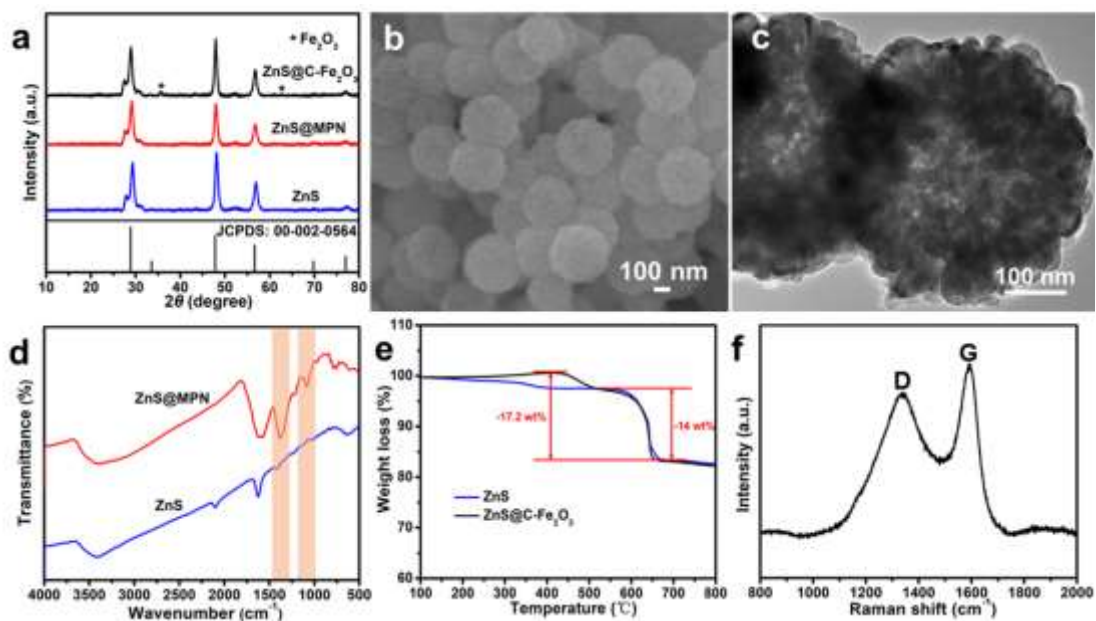


Fig. S10 (a) XRD patterns of ZnS, ZnS@MPN and ZnS@C-Fe₂O₃ hollow spheres. (b, c) SEM and TEM images of ZnS hollow spheres, respectively. (d) FT-IR spectra of ZnS and ZnS@MPN. (e, f) TG curve and Raman spectrum of ZnS@C-Fe₂O₃, respectively.

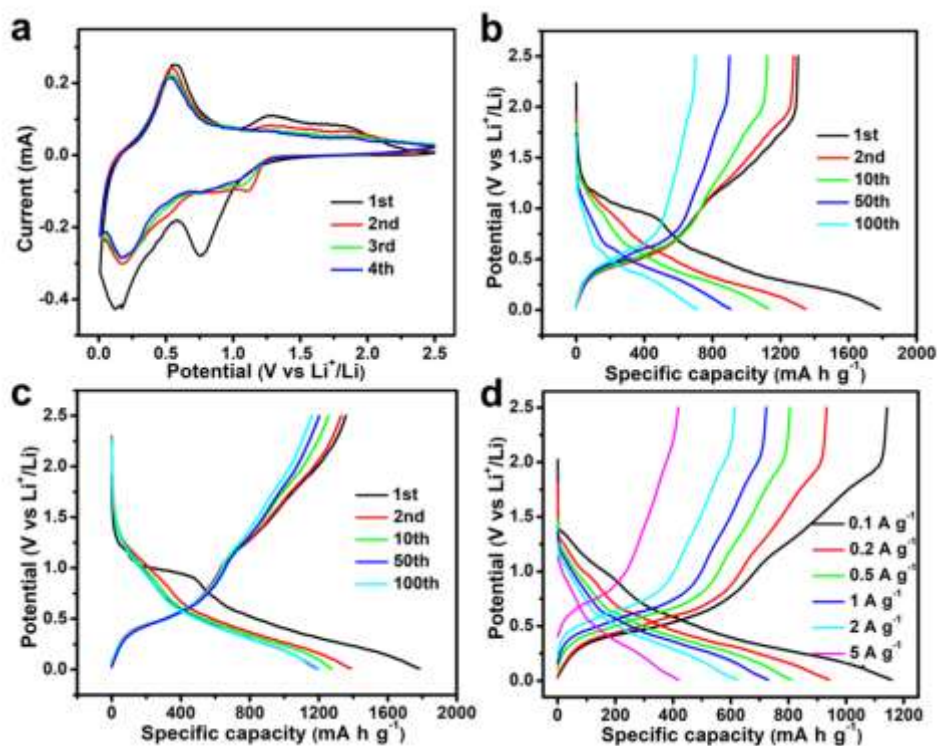


Fig. S11 (a) CV curves of the first four cycles at the scan rate of 0.2 mV s⁻¹ of SnO₂ in the 0.01-2.5 V range. (b, c) Charge-discharge curves (for the 1st, 2nd, 10th, 50th and 100th cycles).

100th cycle at the rate of 0.2 A g^{-1}) of SnO_2 and $\text{SnO}_2@\text{C-Fe}_2\text{O}_3$ -10, respectively. (d) The charge-discharge voltage profiles of the SnO_2 at different current densities.

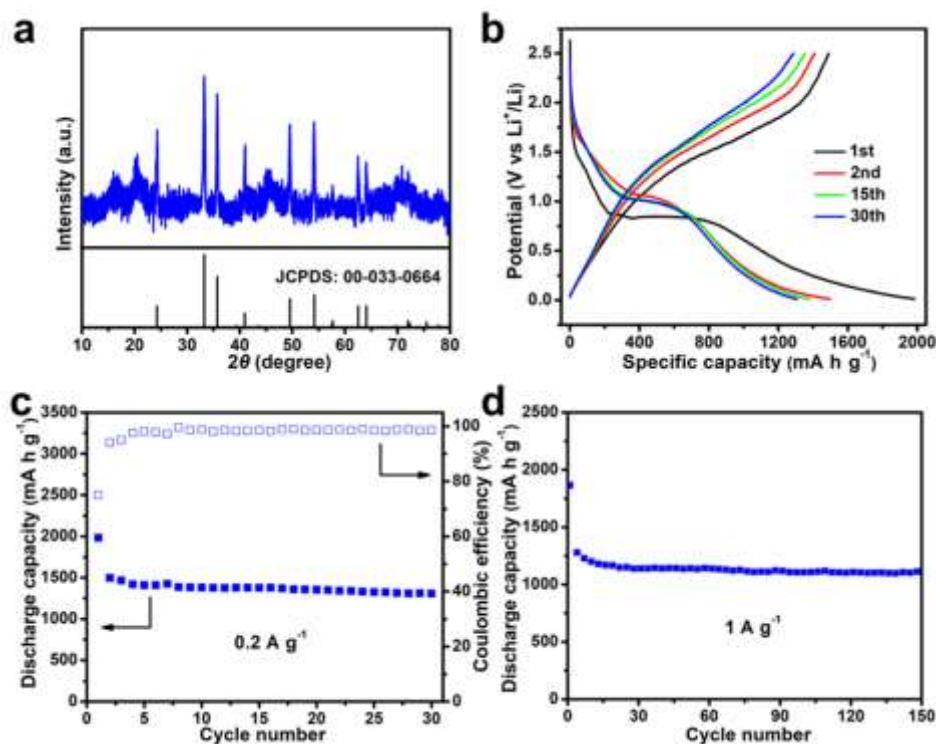


Fig. S12 (a) XRD patterns of the $\text{C-Fe}_2\text{O}_3$ derived from pure MPN. (b) Charge-discharge curves (for the 1st, 2nd, 15th and 30th cycle at 0.2 A g^{-1}) of $\text{C-Fe}_2\text{O}_3$. (c) Cycling performance and the corresponding Coulombic efficiencies of $\text{C-Fe}_2\text{O}_3$ at 0.2 A g^{-1} . (d) Long-term cycling performance of $\text{C-Fe}_2\text{O}_3$ at 1 A g^{-1} .

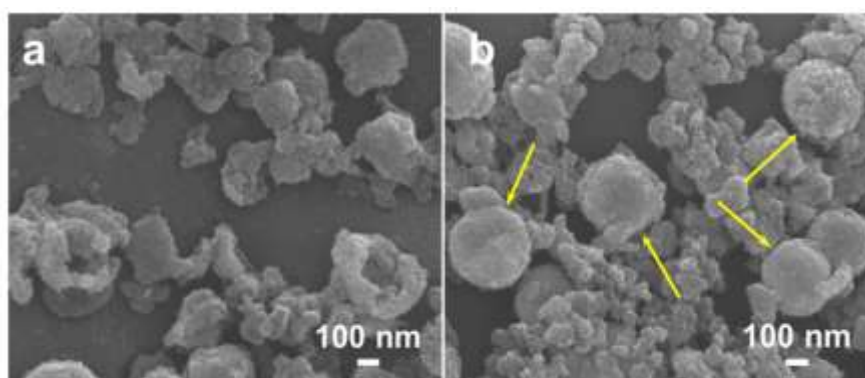


Fig. S13 (a, b) SEM images after 100 cycles at 0.2 A g^{-1} for SnO_2 and $\text{SnO}_2@\text{C-Fe}_2\text{O}_3$ -10, respectively.

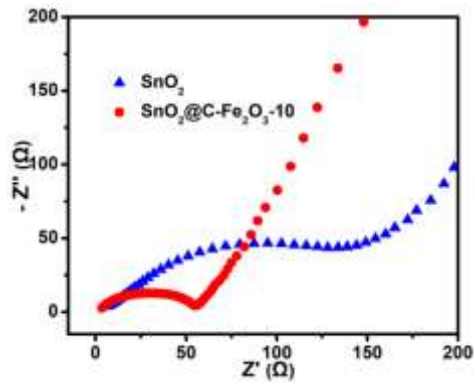


Fig. S14 Nyquist plots measured at 2.5 V in the frequency range of 100 kHz-0.01 Hz.

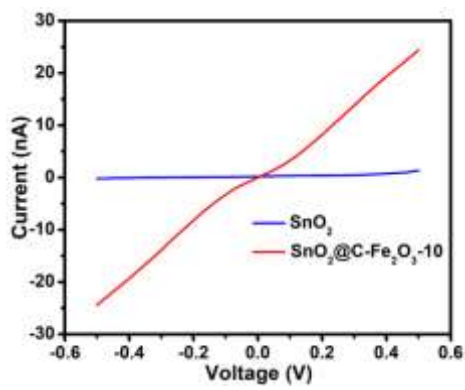


Fig. S15 I-V curves of SnO_2 and $\text{SnO}_2@\text{C-Fe}_2\text{O}_3\text{-10}$.

Table S1. The ICP test results of the SnO₂@C-Fe₂O₃-1, SnO₂@C-Fe₂O₃-3, SnO₂@C-Fe₂O₃-7, SnO₂@C-Fe₂O₃-10, SnO₂@C-Fe₂O₃-15 and SnO₂@C-Fe₂O₃-20.

Material	Sn : Fe	The content of Fe ₂ O ₃ (wt%)
SnO ₂ @C-Fe ₂ O ₃ -1	0.9942 : 0.0058	0.61
SnO ₂ @C-Fe ₂ O ₃ -3	0.9843 : 0.0157	1.64
SnO ₂ @C-Fe ₂ O ₃ -7	0.9644 : 0.0356	3.64
SnO ₂ @C-Fe ₂ O ₃ -10	0.9477 : 0.0523	5.28
SnO ₂ @C-Fe ₂ O ₃ -15	0.9496 : 0.0804	7.98
SnO ₂ @C-Fe ₂ O ₃ -20	0.8754 : 0.1246	12.12

Table S2. A comparison of our work and conventional carbon coating methods.

Coating methods	Coating sources	Advantages	Disadvantages	References
Metal-phenolic network modification	MPN	<ul style="list-style-type: none"> • Precise control • Simple and fast manipulation • Programmable process • No substrate selectivity • Low cost 	<ul style="list-style-type: none"> • Solvent consuming 	Our work
Solution-based polymerization	Dopamine	<ul style="list-style-type: none"> • Simple manipulation • Low cost • No substrate selectivity 	<ul style="list-style-type: none"> • Solvent consuming • Tedious synthesis process • Hard control on uniform coatings 	<i>Adv. Mater.</i> 2017, 29 , 1700989.
Low-pressure vapor superassembly	MOFs	<ul style="list-style-type: none"> • No solvent consuming • Low cost • Simple manipulation 	<ul style="list-style-type: none"> • Substrate material selectivity • Hard control on precise coatings 	<i>Nano Lett.</i> 2017, 17 , 7773-7781.

			<ul style="list-style-type: none"> • Some requirements of operation condition 	
Sol-gel method	Citric acid	<ul style="list-style-type: none"> • Simple manipulation • Low cost • No substrate selectivity 	<ul style="list-style-type: none"> • Hard control on uniform coatings • Solvent consuming • Tedious synthesis process 	<i>J. Alloys Compd.</i> 2011, 509 , 712-718.
Chemical vapor deposition	Carbon	<ul style="list-style-type: none"> • Precise control • Uniform deposition • High quality coatings 	<ul style="list-style-type: none"> • Complex manipulation • High cost • High requirements of operation condition 	<i>J. Mater. Chem.</i> 2010, 20 , 595-602.
Atomic layer deposition	Metal organic compounds	<ul style="list-style-type: none"> • Uniform and conformal deposition • High quality coatings • Precise control 	<ul style="list-style-type: none"> • High cost • Complex manipulation • High requirements of operation condition 	<i>Energy Environ. Sci.</i> , 2012, 5 , 6872-6879.

Table S3. Electrochemical performance comparison of various modified SnO₂ anode.

SnO ₂ anode	Voltage range (V)	Current density (mA g ⁻¹)	Cycle number	Residual capacity (mA h g ⁻¹)	Capacity retention	Reference
SnO₂@C-Fe₂O₃-10	0.01-	200	100	1203	91 %	Our work
	2.5	1000	1000	1003	86 %	
Hollow structured						
SnO ₂ @Si nanospheres	0.01-1	300	500	778	86 %	S1
RGO/SnO ₂ composites	0.01-2	100	200	718	79 %	S2
Silver						
nanoparticle-decorated SnO ₂ /NiO nanotubes	0.01-3	1000	500	826	81 %	S3
rGO enwrapping						
hollow SnO ₂ nanospheres	0.01-3	100	100	1107	82 %	S4
Sandwiched						
C@SnO ₂ @C hollow structures	0.005-3	100	50	933	93 %	S5
Ultrafine						
SnO ₂ /graphene nanocomposite	0.01-3	1000	230	970	97 %	S6
SnO ₂ @Fe ₂ O ₃ sandwich cubes	0.01-3	100	200	750.8	83 %	S7

Carbon coated SnO ₂ nanoparticles anchored on CNT	0.01-2.5	1000	150	930	81 %	S8
Okra-like SnO ₂ encapsulated in nitrogen-doped graphene	0.01-3	200	180	1041	76.4 %	S9
Porous micron-SnO ₂ /C composites	0.01-3	200	100	954	96 %	S10

References

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